MetaXpress® 6 Guide

Autofocus Options

April 2021 revB



Overview

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 - What is Laser Autofocus (LAF)?
 - What is Image-based Autofocus (IAF)?
 - What is a combination of Laser Autofocus (LAF) and Image Autofocus (IAF)?
- Software Settings
 - Enabling Laser-based Autofocus (LAF) Alone
 - Enabling Image-based Autofocus (IAF) Alone
 - Enabling All Autofocus Options (Recommended)
 - Well-to-Well Laser Autofocus Options
 - When Do I Need to Optimize Laser Autofocus Settings?
- Focus Routine Selection Guide & Notes
- Support resources



Module Purpose

The purpose of this module is to familiarize the user with the different focus options including the Laser Autofocus (LAF) and Image-based Autofocus (IAF) on the ImageXpress instruments with MetaXpress software



What is Autofocus?

Autofocus is the process by which the instrument automatically adjusts the objective so the sample is in focus.

In the MetaXpress software there are different options to achieve focus:

- 1. Laser Autofocus (LAF) also known as hardware autofocus
- 2. Image-based Autofocus (IAF) also known as software autofocus
- 3. Combinations of the above.



What is Laser Autofocus (LAF)?



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- A dedicated focus laser detects reflections at different surfaces
- The objective moves to the focus position by locating the reflection from the plate bottom and/or well bottom
- The laser autofocus mechanism uses a 690nm laser and dedicated focus camera
- Laser autofocus is independent of the cells and the staining

What is Image Autofocus (IAF)?



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- Image-based Autofocus (IAF) uses the following routine:
- 1. The sample is illuminated at the chosen wavelength.
- 2. The selected objective moves up and down with a large step size to capture images of the sample at a range of focus (Z) heights.
- 3. The software evaluates the captured images for contrast.
- 4. The software iteratively narrows the search range and reduces the step size, minimizing the number of steps/images required.
- 5. The instrument captures the final image at the focus height giving the greatest contrast.

Combination of Laser and Image Autofocus



When a combination of LAF and IAF is selected:

- 1. The instrument first uses the LAF routine to find focus for the plate and/or well bottom.
- 2. The instrument then uses the IAF to optimize focus based on the specific sample.

When is a combination of LAF & IAF useful?

- · Multiple cell types in the same sample plate
- Stains that move between cellular compartments with different focal planes
- Sample in mounting media, which can interfere with LAF
- Samples in a thick matrix such as Matrigel
- Suspension cells
- Whole organisms

Autofocus Settings in MetaXpress 6

- Enabling Laser-based Autofocus (LAF) alone
- Enabling Image-based Autofocus (IAF) alone
- Enabling All Autofocus options (Recommended)
- Well-to-Well Laser Autofocus options
- Find Sample options
- Site Autofocus options
- Timelapse Autofocus options
- Autofocus Routine Selection Guide
- When Do I Need to Optimize Laser Autofocus Settings?



Enabling Laser-based Autofocus (LAF) Alone

- Plate Acquisition Setup > Acquisition tab
 - Select Enable laser-based focusing
 - Deselect Enable image-based focusing
- W1 autofocus options:
 - Laser with z-offset
- W2 W8 autofocus options:
 - Z-offset from W1
- LAF alone is the default setting:
 - Fastest performance
 - Minimizes photobleaching
 - Independent of sample/stain quality

Autofocus options

- Enable laser-based focusing
- Enable image-based focusing (for acquisition or laser recovery)

aser with z-offset	Post-laser offset (um) ▼ 0 🚖		
Baci Will 2 Onact			
		Bange (um) Step (um)	



Enabling Image-based Autofocus (IAF) Alone

- Plate Acquisition Setup > Acquisition tab
 - Deselect Enable laser-based focusing
 - Select Enable image-based focusing
- W1 Autofocus options:
 - Image-based
- W2 W8 Autofocus options:
 - Image-based

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- Z-offset from W1
- Using IAF alone is generally not recommended, but can occasionally be useful when:
 - LAF has not been configured for your chosen plate/objective
 - LAF fails due to plate imperfections, low volume, or the presence of mounting media



- Enable laser-based focusing
- Enable image-based focusing (for acquisition or laser recovery)

	Image-based Max.ste range +/-(um): (um):
Image-based	200 🖨 5

Enabling All Autofocus Options (Recommended)

- Plate Acquisition Setup > Acquisition tab
 - Select Enable laser-based focusing
 - Select Enable image-based focusing
- W1 autofocus options
 - Laser with z-offset
 - Laser And Image
 - Laser with Image Recovery
- W2 W8 autofocus options
 - Z-offset from W1
 - Image-based

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- Plate Acquisition Setup > Autofocus tab
 - Enable Allow image-based focusing for recovery from laser-based well bottom failures

Objective and Camera- 10X F	Autofocus options			
Plate- 96 Wells -8x12- test	Enable laser-based focusing			
Sites to Visit- single site	Enable image-based focusing (for acquisition or laser recovery)			
Acquisition	Acquisition options			
<u> </u>				
1Manual and the				
Wavelengths				
W1 Cy5	None 👻			
	None			
	Laser with z-offset			
	Laser And Image			
	Laser with Image Necovery			
Acquisition	Well to well autofocus Focus on well bottom			
Autofocus	Image based Foot joing			
Wavelengths				
W1 Cy5	Algonithm: Standard V Binning: 2 T Custom exposure tin			
Sector and the sector of the s	Allow image based for using for recovery from laser based well bottom failures			

Well to well Laser Autofocus Options

Well-to-well option	When to use		
Focus on well bottom	 Thicker plates with 10x and above Very flat thin plates with 10x and above For fastest performance 		
Focus on plate bottom, then offset by bottom thickness	 Most plates with 4x and 2x objectives Slide/coverslips with all objectives Together with IAF for all objectives with: Samples in thick matrices (Matrigel) Ultra-thin plates 		
Focus on plate and well bottom	 Most thin plates with 10x and above When Focus on well bottom gives inconsistent results 		
Well to well autofocus Focus on well bottom Focus on well bottom Focus on plate bottom, then offset by bottom thickness Focus on plate and well bottom	• Thicker plates: Physical bottom thickness ≥ 0.35 mm Optical thickness ≥ 220 um • Thin plates: 0.15 mm < Physical bottom thickness < 0.35 mm 100 um < Optical thickness < 220 um		

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Find Sample Options

Initial well for finding sample	When to use		
First well acquired	Most of the time		
Specific well	 When First well acquired gives errors When using IAF only and the first well to be acquired doesn't have a bright sample When you have already manually focused on the sample, and First well acquired gives inaccurate focus When to use 		
Skip Find Sample			
Number of wells to attempt initial find sample			
3 or higher	When using automated plate loading		
Initial well for finding sample First well acquired A 1 1 Number of wells to attempt ini Specific well Skip Find Sample (select if sample is already in focus) Skip Find Sample (select if sample is already in focus) Site Autofocus All sites Image: State is already in focus)	Initial well for finding sample First well acquired A 1 Number of wells to attempt initial find sample 3 Image: Compare the same term of the same term of		

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Site Autofocus Options

Site Autofocus Option			When to use	
First site only			For fastest performance	
Center of well only			 Most plates with 4x and 2x objectives Round-bottom plates 	
All sites			 Most of the time with 10x and above 	
	Site Autofocus	All sites First site Center of All sites	only well only	
DEVICES	Only available when acquiring multiple sites per well For research use only. Not for use in diagnostic procedures.		g multiple sites per well earch use only. Not for use in diagnostic procedures. Molecular Devices, LLC, Trademarks are the property of Molecular Devices, LLC or their respective owners. L p14	

Timelapse Autofocus Options

Timelapse Autofocus Option	When to use
First timepoint only	Most fast kinetic assays
All timepoints	Most longer timelapse assays
Every Nth timepoint	• Fast kinetic assays when the focus may occasionally drift (for example after pipetting in compound)



Only available when acquiring multiple time points



Autofocus Routine Selection Guide

	Objective	Plate/Slide Type	Well-to-well autofocus option	Site autofocus option
	1x	Any plateAny slide	None (Use fixed focus across the plate)	None (Use fixed focus across the plate)
	2x, 4x • Any plate • Any slide		Focus on plate bottom then offset by bottom thickness	Center of well only
	10x and above • Thin plate		Focus on plate and well bottom	All sites for flat-bottom plate Center of well only for round-bottom plate
	10x and above • Slide with coverslip • Ultra-thin plate • Plate with Matrigel		Focus on plate bottom then offset by bottom thickness IAF may also be needed	All sites for flat-bottom plate Center of well only for round-bottom plate
	10x, 20x, 40x ELWD, 60x ELWD	Thicker plateChamber slide with wells	Focus on well bottom	All sites for flat-bottom plate Center of well only for round-bottom plate
	40x Plan Apo or other high-mag short working distance objective	Thin plate (avoid edge wells)(Do not use thick plates)	Focus on plate and well bottom	All sites for flat-bottom plate Center of well only for round-bottom plate
	Thicker Thin pla Ultra-thi	plates: Physical bottom thickness ≥ 0.35 Optical thickness ≥ 220 um tes: 0.15 mm < Physical bottom thick	5 mm kness < 0.35 mm 20 um 5 mm	
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Additional notes on Autofocus Routines

- 1. 2x and 4x objectives: For these low-magnification objectives, the plate and well bottom laser reflections cannot reliably be distinguished because of the wide depth of field.
- 2. Thin-bottom plates: For thin-bottom plates with high variation, the large search range for the well bottom may accidentally detect the plate bottom. The **Focus on plate and well bottom** option forces the system to search for both surfaces.
- 3. Short working distance objectives: These objectives may bump the skirt of the plate when focusing on edge wells, pushing the plate up.
- 4. Matrigel-based samples: The LAF cannot detect the Matrigel or the cells. The LAF locates the plate bottom and a smaller image-based autofocus is used to find the cells.
- 5. Slides with coverslips: There is no equivalent well bottom to produce a reflection at the interface between the coverslip, mounting media, and slide. Generally if the sample is located on the bottom surface (e.g. **cells on the coverslip/coverslip down** or **tissue on the slide/coverslip up**) then **LAF alone** is sufficient. If the sample is on the top surface (e.g. **tissue on the slide / coverslip down**) then you may need **LAF + IAF**.



When Do I Need to Optimize Laser Autofocus Settings?

- When working with a new batch/lot of plates from the manufacturer
- If you are seeing many out of focus images
- When the software is very slow or unresponsive after clicking the **Focus** or **Test** buttons
- When plate acquisition time is taking longer than expected, or acquisition speed generally needs improvement
- If you see the error "The initial autofocus failed to find the plate"
- If the automated plate loading system is reporting error 14, and the plate was loaded correctly







Support Resources

- F1 / HELP within MetaXpress® Software
- Support and Knowledge Base: <u>https://support.moleculardevices.com/</u>
- Contact us: <u>https://www.moleculardevices.com/contact</u>

